



Surface-mount Ceramic Multilayer Capacitors - Soft Termination Series

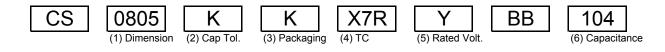
CS0805KKX7RYBB104 (0805,X7R, 100nF, 250V, ±10%)

Spec Sheet

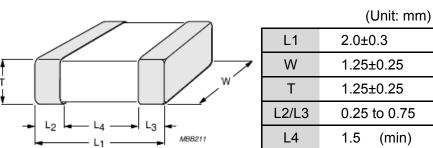
Scope

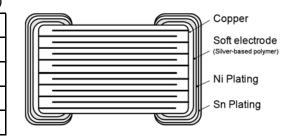
This product specification is applied to Multi-layer Ceramic Capacitor with soft termination.

Yageo Part Number



(1) External Dimensions





(2) Capacitance Tolerance:	±10%
(4) Temperature Characteristics:	X7R
Temperature Range:	-55 to 125 $^{\circ}\mathrm{C}$
Cap Change:	±15%
(5) Rated Voltage:	250V
(6) Capacitance:	100nF
(3) Package:	Embossed Plastic Tape Reel 7"
Packaging Unit:	3,000 pcs
Insulation Resistance:	R x C > 500Ω.F
Dielectric Loss Tangent:	2.5%
RoHS Compliance:	Yes
Halogen Free:	Yes
Soldering Method:	Reflow/Wave





IEC-60384 Standard Specification and Test methods

Test Item	Procedure	Requirements
Mounting	The capacitors may be mounted on printed-circuit boards or	No visible damage
	ceramic substrates.	
Visual inspection and	Any applicable method using x10 magnification	In accordance with specification
dimension check		
Capacitance	Class1:	Within specified tolerance
	C ≤1nF, f = 1 MHz;	
Dielectric loss tangent	C > 1nF, f = 1 KHz;	
	NPO: measuring voltage 1 V at room temp.	
	Class 2 (X5R, X7R) :	
	Precondition:	
	150 +0/-10 $^{\circ}\text{C}$ /1 hr , then keep for 24±1 hrs at room temp.	
	f = 1 kHz; measuring voltage 1 V at 20℃	
Insulation resistance	At Ur (DC) for 1 minute	In accordance with specification
	Ur(DC) > 500V: At 500V for 1 minute	
Temperature coefficient	Capacitance shall be measured by the steps shown in the	Class I:
	following table.	Δ C/C: ±30ppm
	The capacitance change should be measured after 5 min at	
	each specified temperature stage.	Class II:
	Step Temperature	X7R/ X5R: Δ C/C: ±15%
	a 25±2	Y5V: Δ C/C: +22~-82%
	b Lower Temperature ±3	
	c 25±2	
	d Upper Temperature ±2	
	e 25±2	
	(1) Class I	
	Temperature Coefficient shall be calculated from the formula	
	as below:	
	Temp, Coefficient = $\frac{\text{C2 - C1}}{\text{C1} \times \triangle \text{T}} \times 10^6 \text{ [ppm/C]}$	
	C1: Capacitance at step c	
C2: Capacitance at 125℃ △T: 100℃ (=125℃ -25℃)		
	(2) Class II	
	Capacitance Change shall be calculated from the formula	
	as below.	
	$\triangle C = \frac{C2 - C1}{C1} \times 100(\%)$	
C1: Capacitance at step c		
	C2: Capacitance at step b or d	





IEC-60384 Standard Specification and Test methods

Test Item	Procedure	Requirements
Adhesion	A force applied for 10 sec to the line joining the terminations	Force:
	and in a plane parallel to the substrate.	size≥0603: ≥5N, size=0402: ≥2.5N, size≤0201: ≥1N
Bending Strength	Mounting in accordance with IEC 60384-22 paragraph 4.3	No visible damage
	Conditions:	Δ C/C: Class I, within ±1% or 0.5 pF, whichever is greater
	Bending 5mm at a rate of 1 mm/s, radius jig 230 mm,	Class II: X7R, X5R:±10%,
	holding time 5 ± 1 sec.	
	NPO: 5 mm, X7R/0402 to 0603: 5 mm, 0805 to 1812: 3mm	
	Speed: 1mm/s R230 Flexure Capacitance meter 45 45	
Resistance to soldering heat	Precondition:	Dissolution of the end face plating shall not exceed 25%
	150 +0/-10 ℃/1 hr, then keep for 24±1 hrs at room temp	of the length of the edge concerned.
	Preheating: for size >1206:100 to 120 °C for 1 minute and	Δ C/C:
	170 to 200°C for 1 minute.	Class I, within ±0.5% or 0.5 pF, whichever is greater
	Solder bath temperature: 260 ± 5°C	Class II: X7R:±12.5%,
	Dipping time 10±0.5 s	DF: within initial specified value
	Recovery time 24±2 Hours.	IR: within initial specified value
Solderability	The specimen shall be preheated to a temperature of	The solder should cover over 95% of the critical area
	80 to 140 $^{\circ}\mathrm{C}$ and maintained for 30s to 60s.	of each termination.
	1. Temperature: 235±5°C / Dipping time: 2 ±0.5 s	
	2. Temperature: 245±5°C / Dipping time: 3 ±0.5 s (lead free)	
	Depth of immersion: 10mm	
Rapid change of temperature	Precondition:	No visual damage
	150 +0/-10°C/1 hr, then keep for 24±1 hrs at room temp	Δ C/C:
	5 cycles with following detail:	Class I, within ±1% or 1 pF, whichever is greater
	30 minutes at Lower Category Temperature;	Class II: X7R, X5R:±15%,
	30 minutes at Upper Category Temperature;	DF: within initial specified value
	Recovery time 24±2 Hours.	IR: within initial specified value





IEC-60384 Standard Specification and Test methods

Test Item	Procedure	Requirements
Damp heat with Ur load	1. Precondition (Class II only):	No visual damage after recovery
	150 +0/-10°C/1 hr, then keep for 24±1 hrs at room temp	Δ C/C:
	2. Initial measure	Class I, within ±2% or 1 pF, whichever is greater
	Spec: refer Initial spec (Cap, DF, IR)	Class II: X7R:±15%,
	3. Damp heat test:	DF:
	500±12 hours at 40±2°C; 90 to 95% R.H.; 1.0Ur applied	2 x Specified value
	4. Recovery:	IR:
	Class 1: 6 to 24 hours, Class 2: 24±2 hours	Class I:
	5. Final measure:	\ge 2,500MΩ or RxC \ge 25Ω.F whichever is less
	Cap, DF, IR	Class II:
		${\geq}500M\Omega$ or RxC ${\geq}25\Omega.F$ whichever is less
	X7R/0805/4.7μF/16V ;	ΔC/C : ±20%
	X7R/1206/10μF/16V to 25V ;	D.F.: ≤ 2 x specified value
	X7R/1210/2.2μF to 10μF/16V to 50V;	IR:
	X7R/1210/2.2μF/100V;	$R \times C \ge 5 \Omega . F$
Endurance	1. Precondition (Class II only):	No visual damage after recovery
	150 +0/-10°C/1 hr, then keep for 24±1 hrs at room temp	Δ C/C:
	2. Initial measure	Class I, within ±2% or 1 pF, whichever is greater
	Spec: refer Initial spec (Cap, DF, IR)	Class II: X7R:±15%,
	3. Endurance test:	DF:
	Temperature:NPO/X7R: 125℃ , X5R: 85℃	2 x Specified value
	Apply below Specified voltage applied for 1000 hrs	IR:
	Voltage NPO X7R	Class I:
	≤ 100V 2.0 x Ur 2.0 x Ur	${\geq}4,\!000\text{M}\Omega$ or RxC ${\geq}40\Omega.F$ whichever is less
	200/250V 1.5 x Ur 1.5 x Ur	Class II:
	≥ IKV	${\geq}1000M\Omega$ or RxC ${\geq}50\Omega.F$ whichever is less
	Recovery time: 24±2 hours	
	5. Final measure:	
	Cap, DF, IR	
* Apply 1.5 x Ur for below items		ΔC/C : ±20%
	X7R/0805/4.7μF/16V ;	D.F.: \leq 2 x specified value
	X7R/1206/10μF/16V to 25V ;	IR:
	X7R/1210/2.2μF to 10μF/16V to 50V; X7R/1210/2.2μF/100V;	$R \times C \ge 10 \Omega.F$
Voltage Proof	Specified stress voltage applied for 1 ~5 sec.	No breakdown or flashover
	$Ur \leq 100 \text{ V: series applied 2.5 Ur}$	
	100 V < Ur \leq 200 V series applied (1.5 Ur + 100)	
	200 V < Ur \leq 500 V series applied (1.3 Ur + 100)	
	Ur = 630 V: 1.3 Ur	
	Ur ≥ 1000 V: 1.2 Ur	
	Charge / Discharge current less than 50mA.	<u> </u>





Shelf Life & Storage Condition

According with international specification JIS 1997.

(1) Storage Condtions: Temperature -5 to 40°C

Relative humidity 40~60%

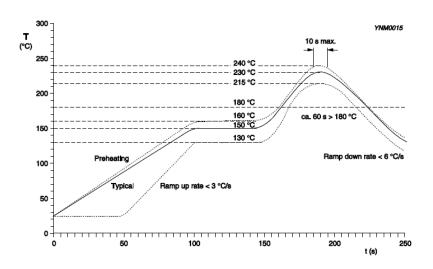
(2) Shelf Life: 2 years from date of manufacture

We recommend that the products are stored in their original packing (e.g. tape, reel).

They should never be touched by hand.

Soldering Condition

For normal use the capacitors may be mounted on printed-circuit boards or ceramic substrates by applying wave soldering, reflow soldering or conductive adhesive in accordance with "IEC 61760-1" (Standard method for the specification of surface mounting components).



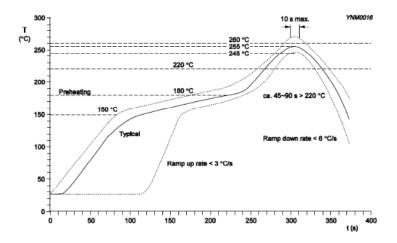
Solid line: Typical process (terminal temperature)

Dotted lines: Process limits - bottom process limit (terminal temperature) & upper process limit (top surface temperature).

Infrared soldering, forced gas convection reflow soldering - Temperature/time profile for SnPb solders



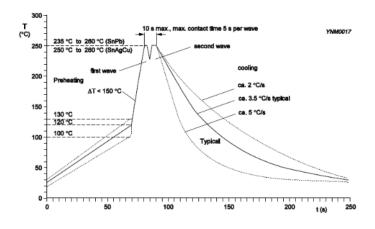




Solid line: Typical process (terminal temperature)

Dotted lines: Process limits - bottom process limit (terminal temperature) & upper process limit (top surface temperature).

Infrared soldering, forced gas convection reflow soldering - Temperature/time profile for lead-free SnAgCu solders



Solid line: Typical process Dotted lines: Process limits

Double wave soldering for SnPb and lead-free SnAgCu solder - Temperature/time profile (terminal temperature)